

- **Controlled Baseline**
 - One Assembly/Test Site, One Fabrication Site
- **Enhanced Diminishing Manufacturing Sources (DMS) Support**
- **Enhanced Product-Change Notification**
- **Qualification Pedigree[†]**
- **21:3 Data Channel Compression at up to 1.36 Gigabits per Second Throughput**
- **Suited for Point-to-Point Subsystem Communication With Very Low EMI**
- **21 Data Channels Plus Clock in Low-Voltage TTL and 3 Data Channels Plus Clock Out Low-Voltage Differential**
- **Operates From a Single 3.3-V Supply and 250 mW (Typ)**
- **5-V Tolerant Data Inputs**
- **'LVDS95 Has Rising Clock Edge Triggered Inputs**
- **Bus Pins Tolerate 6-kV HBM ESD**
- **Packaged in Thin Shrink Small-Outline Package With 20 Mil Terminal Pitch**
- **Consumes <1 mW When Disabled**
- **Wide Phase-Lock Input Frequency Range 20 MHz to 68 MHz**
- **No External Components Required for PLL**

[†] Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not limited to, Highly Accelerated Stress Test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life. Such qualification testing should not be viewed as justifying use of this component beyond specified performance and environmental limits.

- **Inputs Meet or Exceed the Requirements of ANSI EIA/TIA-644 Standard**
- **Industrial Temperature Qualified**
 $T_A = -40^\circ\text{C}$ to 85°C
- **Replacement for the National DS90CR215**

DGG PACKAGE
(TOP VIEW)

D4	1	48	D3
V _{CC}	2	47	D2
D5	3	46	GND
D6	4	45	D1
GND	5	44	D0
D7	6	43	NC
D8	7	42	LVDSGND
V _{CC}	8	41	Y0M
D9	9	40	Y0P
D10	10	39	Y1M
GND	11	38	Y1P
D11	12	37	LVDSV _{CC}
D12	13	36	LVDSGND
NC	14	35	Y2M
D13	15	34	Y2P
D14	16	33	CLKOUTM
GND	17	32	CLKOUTP
D15	18	31	LVDSGND
D16	19	30	PLLGND
D17	20	29	PLLV _{CC}
V _{CC}	21	28	PLLGND
D18	22	27	SHTDN
D19	23	26	CLKIN
GND	24	25	D20

description/ordering information

The SN65LVDS95 LVDS serdes (serializer/deserializer) transmitter contains three 7-bit parallel-load serial-out shift registers, a 7× clock synthesizer, and four low-voltage differential signaling (LVDS) line drivers in a single integrated circuit. These functions allow 21 bits of single-ended LVTTL data to be synchronously transmitted over 4 balanced-pair conductors for receipt by a compatible receiver, such as the SN65LVDS96.

When transmitting, data bits D0 through D20 are each loaded into registers of the SN65LVDS95 on the rising edge of the input clock signal (CLKIN). The frequency of CLKIN is multiplied seven times and then used to serially unload the data registers in 7-bit slices. The three serial streams and a phase-locked clock (CLKOUT) are then output to LVDS output drivers. The frequency of CLKOUT is the same as the input clock, CLKIN.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

SN65LVDS95-EP LVDS SERDES TRANSMITTER

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description/ordering information (continued)

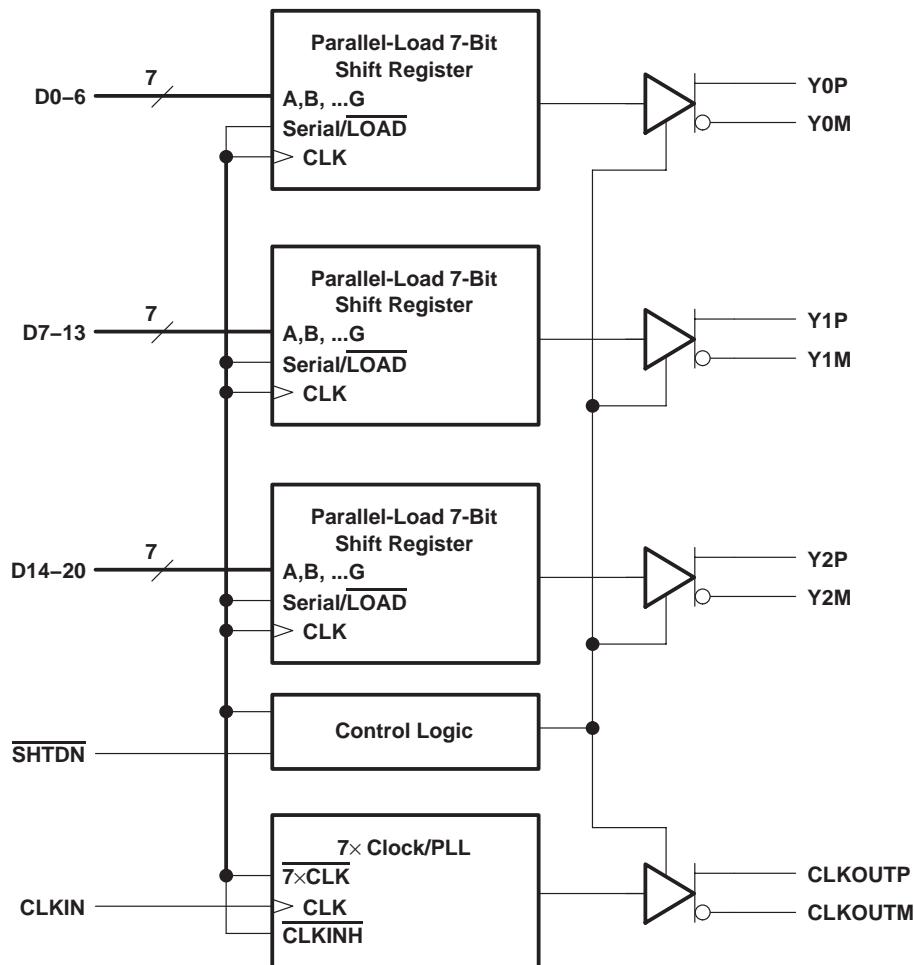
The SN65LVDS95 requires no external components and little or no control. The data bus appears the same at the input to the transmitter and output of the receiver with data transmission transparent to the user(s). The only user intervention is the possible use of the shutdown/clear (\bar{SHTDN}) active-low input to inhibit the clock and shut off the LVDS output drivers for lower power consumption. A low level on this signal clears all internal registers to a low level.

ORDERING INFORMATION

TA	PACKAGE†	ORDERABLE PART NUMBER	TOP-SIDE MARKING
-40°C to 85°C	TSSOP – DGG	SN65LVDS95DGGREP	65LVDS95EP

† Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

functional block diagram



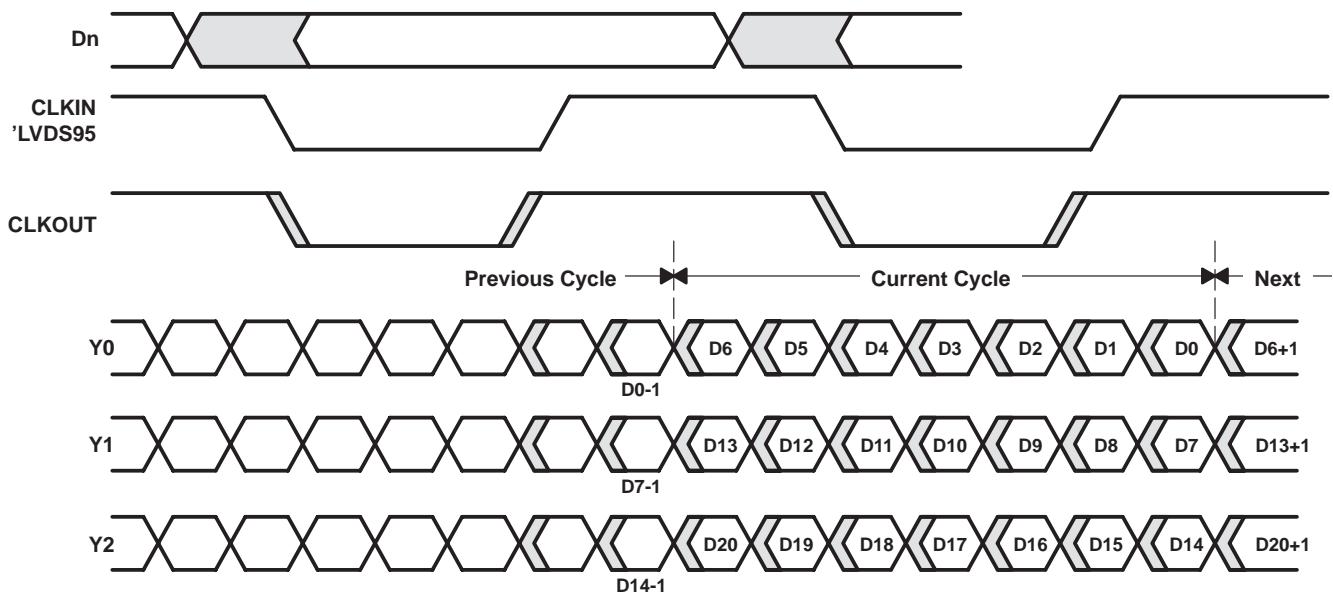
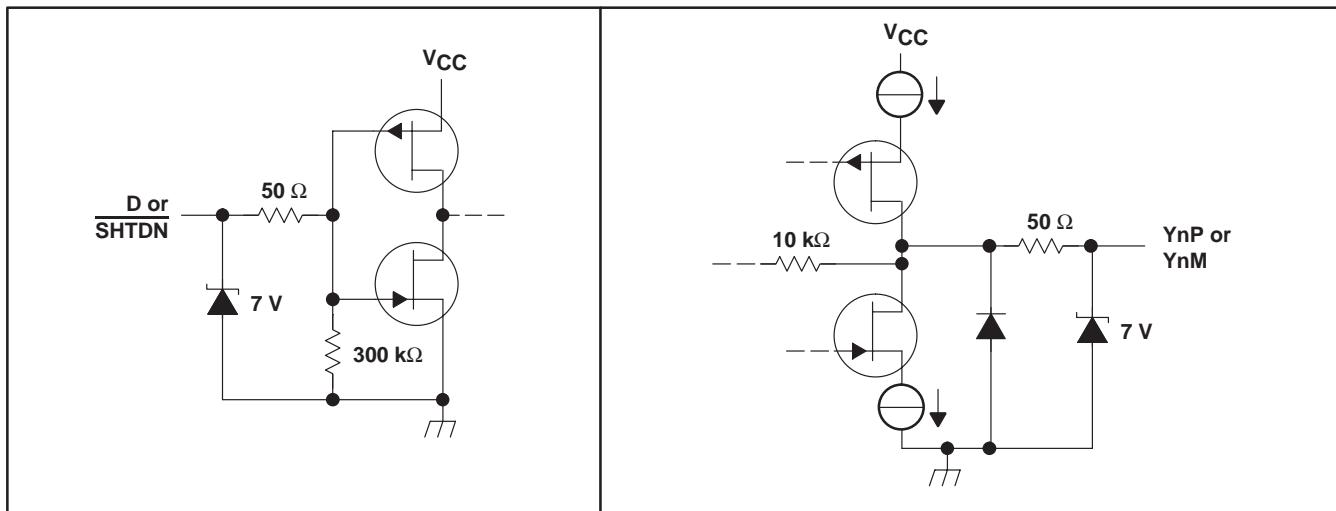


Figure 1. 'LVDS95 Load and Shift Sequences

equivalent input and output schematic diagrams



SN65LVDS95-EP

LVDS SERDES TRANSMITTER

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absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values are with respect to the GND terminals.
2. This rating is measured using MIL-STD-883C Method 3015.7.

DISSIPATION RATING TABLE

PACKAGE	$T_A \leq 25^\circ\text{C}$ POWER RATING	DERATING FACTOR‡ ABOVE $T_A = 25^\circ\text{C}$	$T_A = 70^\circ\text{C}$ POWER RATING	$T_A = 85^\circ\text{C}$ POWER RATING
DGG	1316 mW	13.1 mW/ $^\circ\text{C}$	724 mW	526 mW

‡ This is the inverse of the junction-to-ambient thermal resistance when board-mounted and with no air flow.

recommended operating conditions

	MIN	NOM	MAX	UNIT
Supply voltage, V_{CC}	3	3.3	3.6	V
High-level input voltage, V_{IH}	2			V
Low-level input voltage, V_{IL}			0.8	V
Differential load impedance, Z_L	90	132		Ω
Operating free-air temperature, T_A	-40	85		$^{\circ}C$

electrical characteristics over recommended operating conditions (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP†	MAX	UNIT
V_{IT}	Input voltage threshold		1.4		V
$ V_{OD} $	Differential steady-state output voltage magnitude	$R_L = 100 \Omega$, See Figure 3	247	454	mV
$\Delta V_{OD} $	Change in the steady-state differential output voltage magnitude between opposite binary states			50	
$V_{OC(SS)}$	Steady-state common-mode output voltage	See Figure 3	1.125	1.375	V
$V_{OC(PP)}$	Peak-to-peak common-mode output voltage		80	150	mV
I_{IH}	High-level input current	$V_{IH} = V_{CC}$		20	μA
I_{IL}	Low-level input current	$V_{IL} = 0 V$		± 10	μA
I_{OS}	Short-circuit output current	$V_{OY} = 0 V$		± 24	mA
		$V_{OD} = 0 V$		± 12	mA
I_{OZ}	High-impedance state output current	$V_O = 0 V$ to V_{CC}		± 10	μA
$I_{CC(AVG)}$	Quiescent current (average)	Disabled, all inputs at GND		280	μA
		Enabled, $R_L = 100 \Omega$ (4 places), Worst-case pattern (see Figure 4), $t_C = 15.38$ ns	85	110	mA
C_i	Input capacitance		3		pF

† All typical values are $V_{CC} = 3.3 V$, $T_A = 25^\circ C$.

timing requirements

		MIN	NOM	MAX	UNIT
t_C	Input clock period	14.7	t_C	50	ns
t_W	High-level input clock pulse width duration	0.4 t_C		0.6 t_C	ns
t_t	Input signal transition time			5	ns
t_{SU}	Data setup time, D0 through D27 before CLKIN \uparrow ('95) (see Figure 2)	3			ns
t_h	Data hold time, D0 through D27 after CLKIN \uparrow ('95) (see Figure 2)	1.5			ns

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switching characteristics over recommended operating conditions (unless otherwise noted)

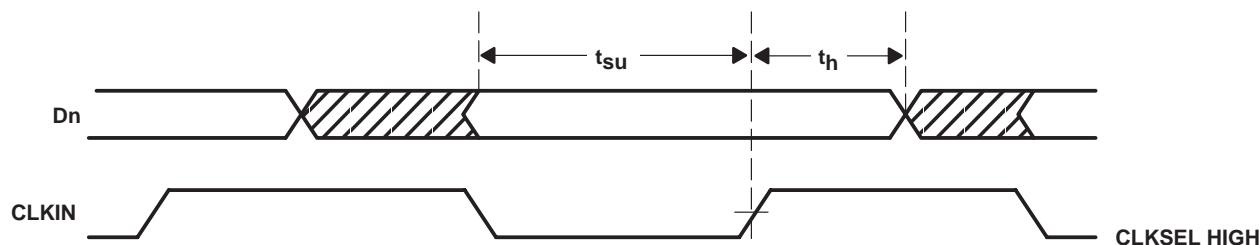
PARAMETER	TEST CONDITIONS	MIN	TYPT [†]	MAX	UNIT
t_0	$t_c = 15.38 \text{ ns} (\pm 0.2\%)$, Input clock jitter < 50 ps [‡] , See Figure 5	-0.20	0	0.20	ns
t_1		1/7 t_c -0.20	1/7 t_c +0.20		ns
t_2		2/7 t_c -0.20	2/7 t_c +0.20		ns
t_3		3/7 t_c -0.20	3/7 t_c +0.20		ns
t_4		4/7 t_c -0.20	4/7 t_c +0.20		ns
t_5		5/7 t_c -0.20	5/7 t_c +0.20		ns
t_6		6/7 t_c -0.20	6/7 t_c +0.20		ns
$t_{sk(0)}$		-0.20	0.20		ns
t_7			4.2		ns
$\Delta t_{C(O)}$	$t_c = 15.38 \text{ ns} (\pm 0.2\%)$, Input clock jitter < 50 ps [‡] , See Figure 5		± 80		ps
	$t_c = 15.38 \text{ ns} + 0.75 \sin(2\pi 500E3t)$ $\pm 0.05 \text{ ns}$, See Figure 6		± 300		ps
t_W			$4/7 t_c$		ns
t_t	See Figure 3	260	700	1500	ps
t_{en}	See Figure 7		1		ms
t_{dis}	See Figure 8		250		ns

[†] All typical values are $V_{CC} = 3.3 \text{ V}$, $T_A = 25^\circ\text{C}$.

[‡] |Input clock jitter| is the magnitude of the change in the input clock period.

[§] The output clock jitter is the change in the output clock period from one cycle to the next cycle observed over 15,000 cycles.

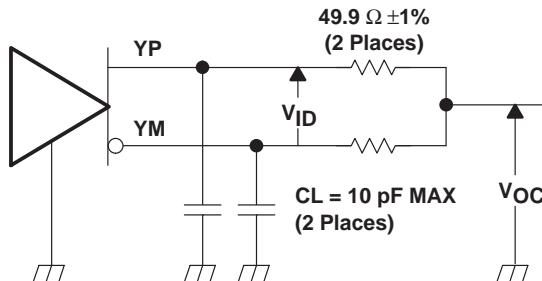
PARAMETER MEASUREMENT INFORMATION



NOTE: All input timing is defined at 1.4 V on an input signal with a 10% to 90% rise or fall time of less than 5 ns.

Figure 2. Setup and Hold Time Definition

PARAMETER MEASUREMENT INFORMATION



NOTE: The lumped instrumentation capacitance for any single ended voltage measurement is less than or equal to 10 pF. When making measurements at YP or YM, the complementary output shall be similarly loaded.

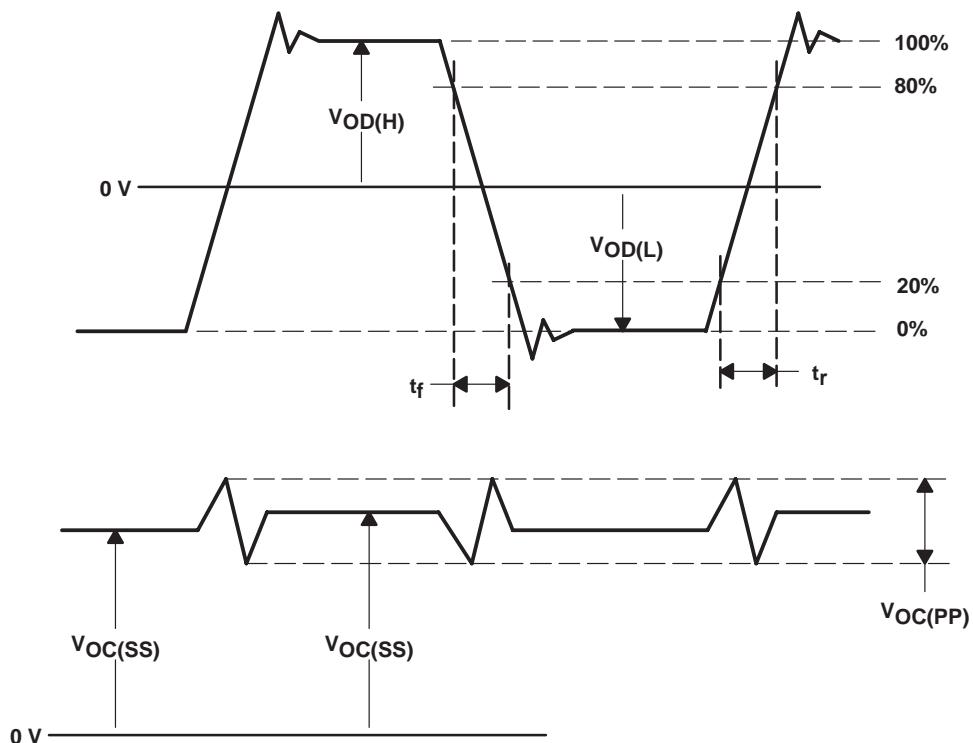


Figure 3. Test Load and Voltage Definitions for LVDS Outputs

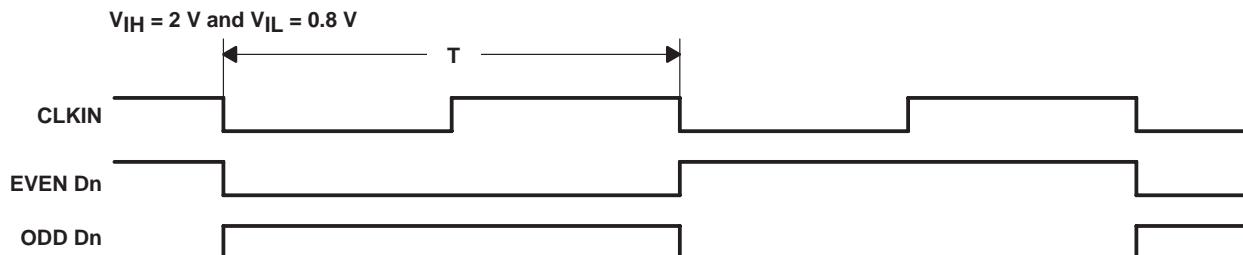


Figure 4. Worst-Case† Power Test Pattern

† The worst-case test pattern produces nearly the maximum switching frequency for all of the LV-TTL outputs.

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PARAMETER MEASUREMENT INFORMATION

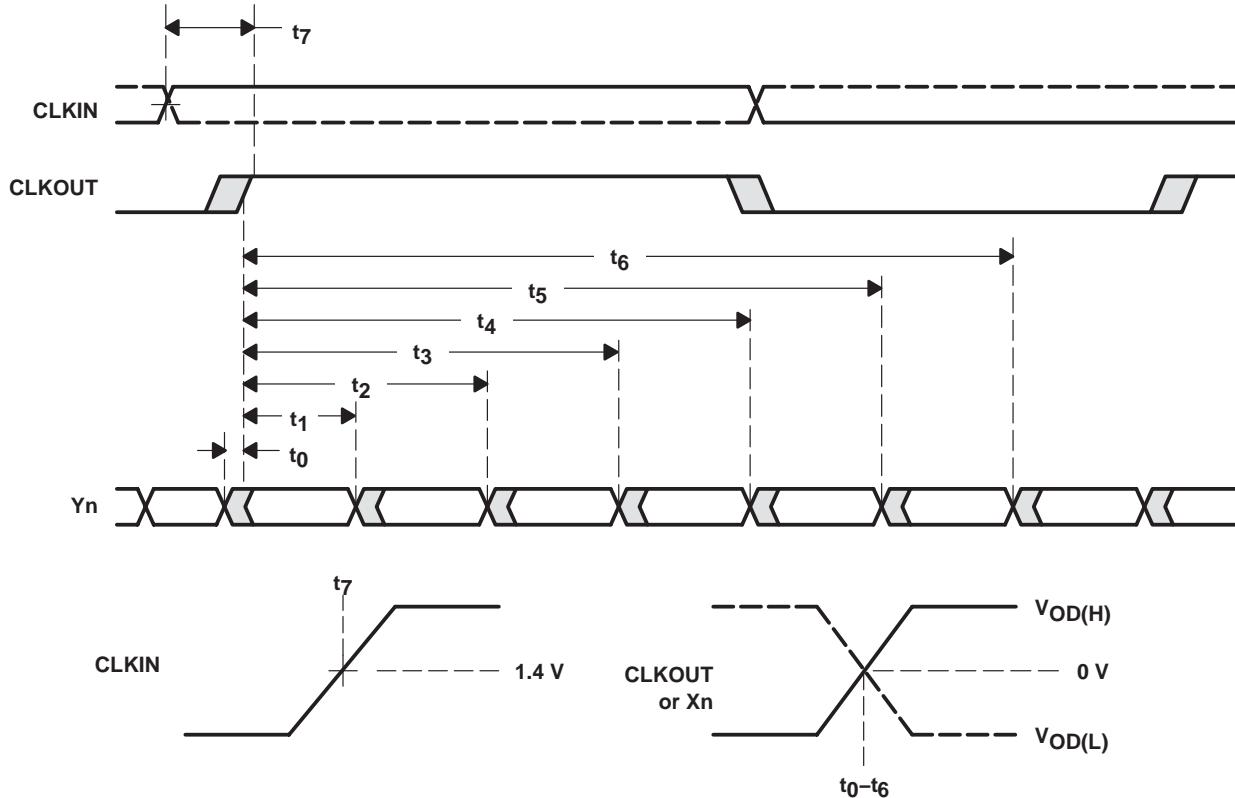


Figure 5. Timing Definitions

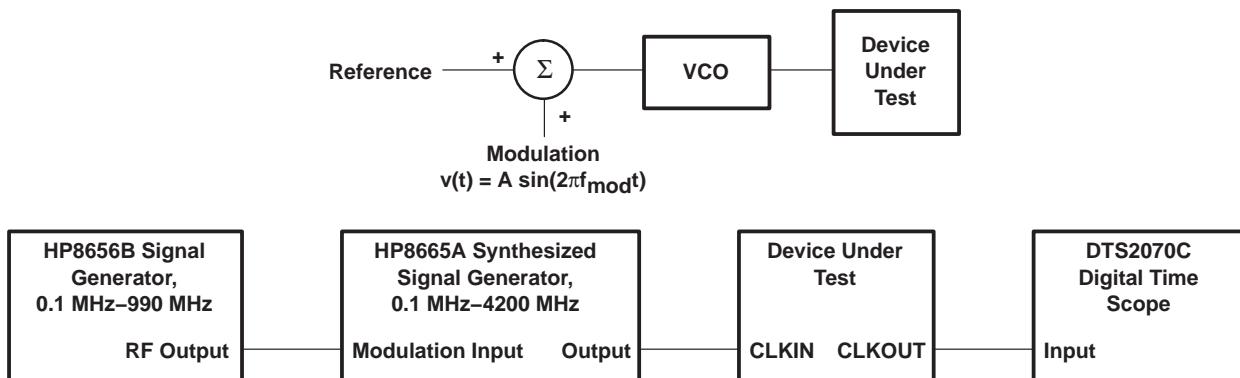


Figure 6. Clock Jitter Test Setup

PARAMETER MEASUREMENT INFORMATION

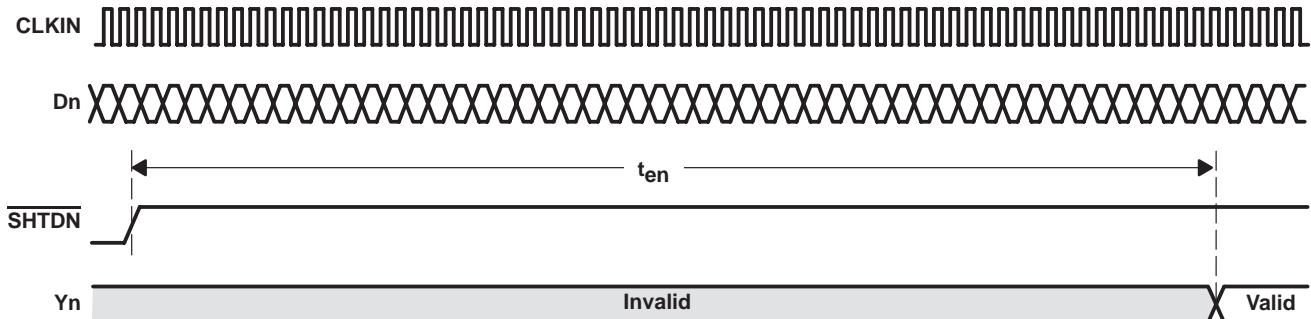


Figure 7. Enable Time Measurement Definition

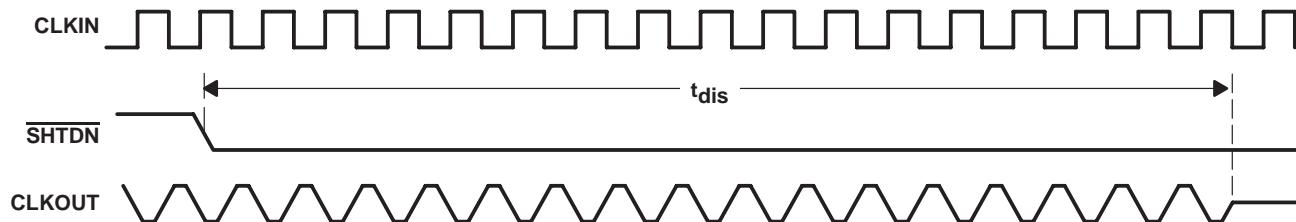


Figure 8. Disable Time Measurement Definition

TYPICAL CHARACTERISTICS

WORST-CASE SUPPLY CURRENT
vs
FREQUENCY

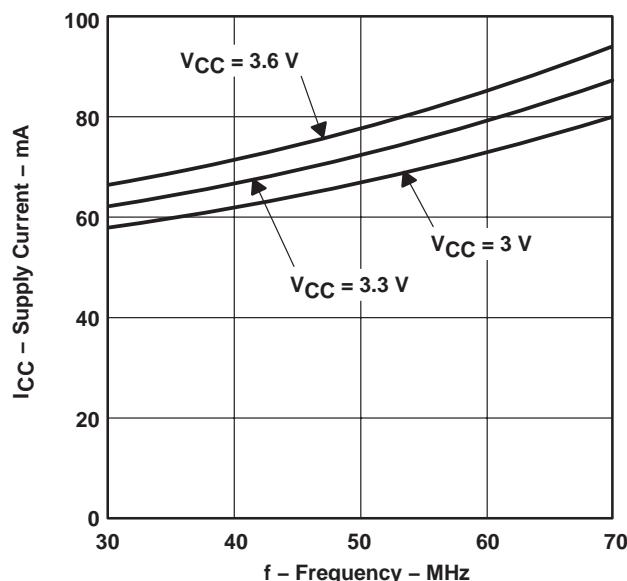


Figure 9

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APPLICATION INFORMATION

16-bit bus extension

In a 16-bit bus application (Figure 10), TTL data and clock coming from bus transceivers that interface the backplane bus arrive at the Tx parallel inputs of the LVDS serdes transmitter. The clock associated with the bus is also connected to the device. The on-chip PLL synchronizes this clock with the parallel data at the input. The data is then multiplexed into three different line drivers which perform the TTL to LVDS conversion. The clock is also converted to LVDS and presented to a separate driver. This synchronized LVDS data and clock at the receiver, which recovers the LVDS data and clock, performs a conversion back to TTL. Data is then demultiplexed into a parallel format. An on-chip PLL synchronizes the received clock with the parallel data, and then all are presented to the parallel output port of the receiver.

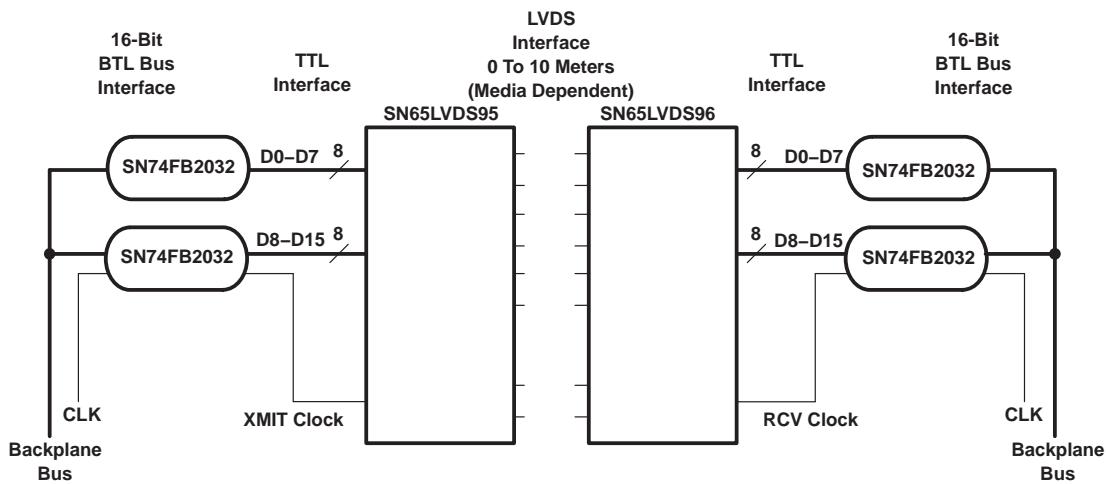


Figure 10. 16-Bit Bus Extension

16-bit bus extension with parity

In the previous application we did not have a checking bit that would provide assurance that the data crosses the link. If we add a parity bit to the previous example, we would have a diagram similar to the one in Figure 11. The device following the SN74FB2032 is a low cost parity generator. Each transmit-side transceiver/parity generator takes the LVTTTL data from the corresponding transceiver, performs a parity calculation over the byte, and then passes the bits with its calculated parity value on the parallel input of the LVDS serdes transmitter. Again, the on-chip PLL synchronizes this transmit clock with the eighteen parallel bits (16 data + 2 parity) at the input. The synchronized LVDS data/parity and clock arrive at the receiver.

The receiver performs the conversion from LVDS to LVTTTL and the transceiver/parity generator performs the parity calculations. These devices compare their corresponding input bytes with the value received on the parity bit. The transceiver/parity generator will assert its parity error output if a mismatch is detected.

APPLICATION INFORMATION

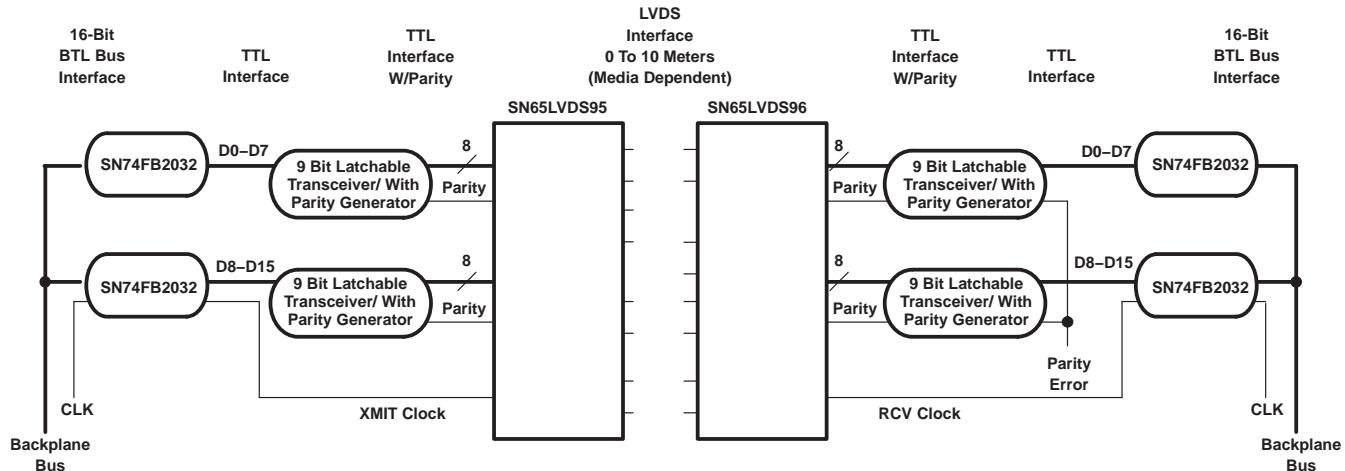


Figure 11. 16-Bit Bus Extension With Parity

low cost virtual backplane transceiver

Figure 12 represents LVDS serdes in an application as a virtual backplane transceiver (VBT). The concept of a VBT can be achieved by implementing individual LVDS serdes chipsets in both directions of subsystem serialized links.

Depending on the application, the designer will face varying choices when implementing a VBT. In addition to the devices shown in Figure 12, functions such as parity and delay lines for control signals could be included. Using additional circuitry, half-duplex or full-duplex operation can be achieved by configuring the clock and control lines properly.

The designer may choose to implement an independent clock oscillator at each end of the link and then use a PLL to synchronize LVDS serdes's parallel I/O to the backplane bus. Resynchronizing FIFOs may also be required.

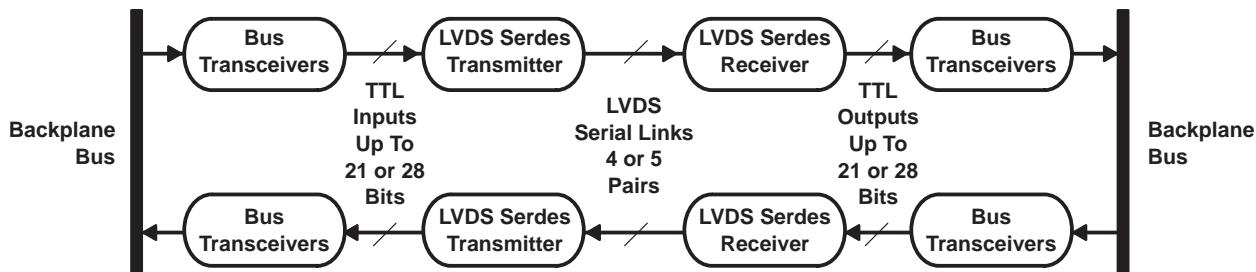


Figure 12. Virtual Backplane Transceiver

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
SN65LVDS95DGGREP	Active	Production	TSSOP (DGG) 48	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	65LVDS95EP
V62/04643-01XE	Active	Production	TSSOP (DGG) 48	2000 LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	65LVDS95EP

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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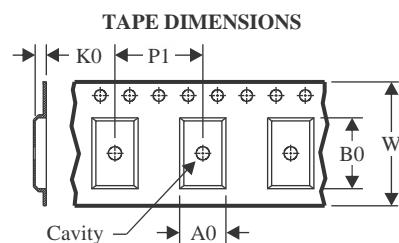
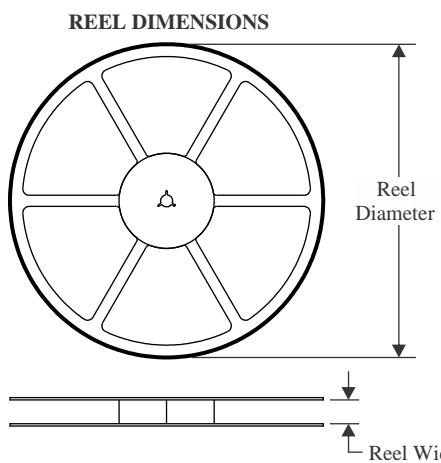
OTHER QUALIFIED VERSIONS OF SN65LVDS95-EP :

- Catalog : [SN65LVDS95](#)

- Automotive : [SN65LVDS95-Q1](#)

NOTE: Qualified Version Definitions:

- Catalog - TI's standard catalog product
- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

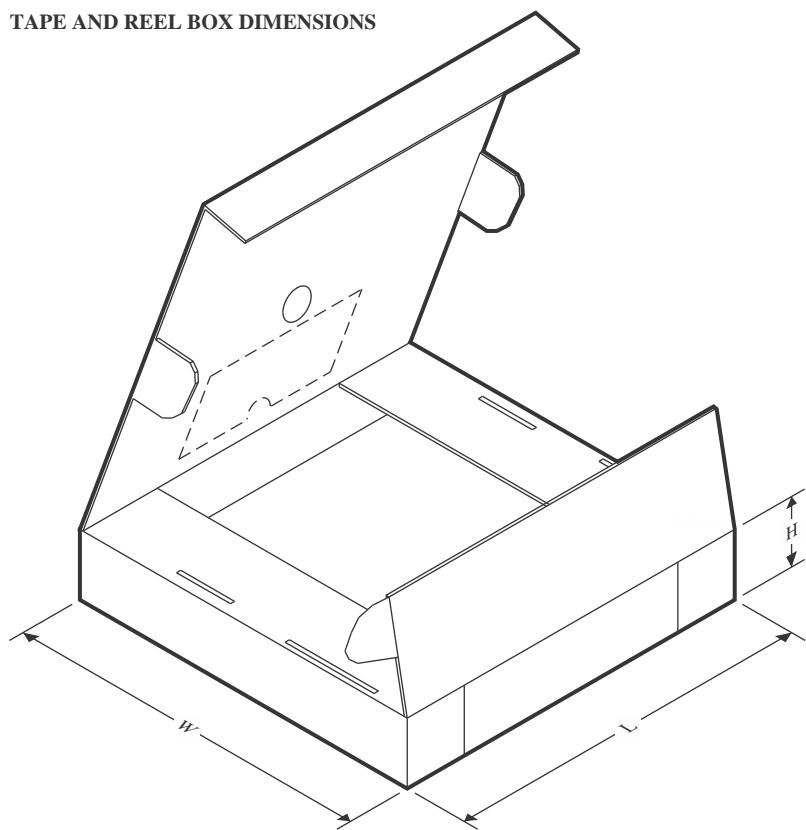
TAPE AND REEL INFORMATION


A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN65LVDS95DGGREP	TSSOP	DGG	48	2000	330.0	24.4	8.6	13.0	1.8	12.0	24.0	Q1

TAPE AND REEL BOX DIMENSIONS


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN65LVDS95DGGREP	TSSOP	DGG	48	2000	350.0	350.0	43.0

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